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APPLICANT:

Shinya Adachi et al.

FILING DATE:

GROUP ART  
UNIT:  
2122

February 14, 2002

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Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date if Appropriate
S.D.	A	6,324,468	11/2001	Meis et al.			
S.D.	B	6,333,703	12/2001	Alewine et al.			
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		Document No.	Date	Country	Class	Subclass	Translation
	Q						
	R						

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

S	
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Examiner: *Seiji Sodehara*

Date Considered 9/28/2005

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	K	Document No.	Date	Country	Class	Subclass	Translation
S. D.	L	WO 00/08616	2/2000	PCT			Eng. Trans. Attached
S. D.	M	WO 01/18768	3/2001	PCT			Eng. Trans. Attached
S. D.	N	WO 01/18769	3/2001	PCT			Eng. Trans. Attached
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Examiner: *Sergey Adshoony*

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Examiner: Segey Selszko gris

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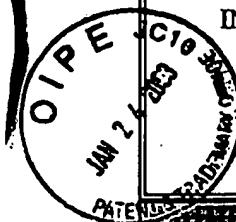
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Examiner: *Segy Adachi et al.*

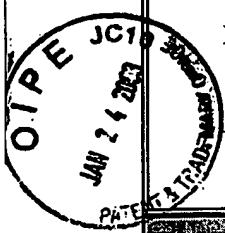
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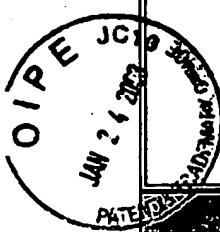
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Examiner: *Seiji Adachi* Date Considered *9/28/2005*

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<b>INFORMATION DISCLOSURE CITATION BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)</b>		<b>APPLICANT: Shinya Adachi et al.</b>	
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S.D.	B	WO 02/16874 A1	02/2002	PCT			Eng. Abstract
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S. D.	G	Abstract of U.S. Patent No. 4,063,237: Date issued: 12/1977
S. D.	H	Abstract of U.S. Patent No. 4,151,656: Date issued: 05/1979
S. D.	I	Abstract of U.S. Patent No. 4,196,474: Date issued: 04/1980
S. D.	J	Abstract of U.S. Patent No. 4,251,797: Date issued: 02/1981
S. D.	K	Abstract of U.S. Patent No. 4,304,487: Date issued: 12/1981
S. D.	L	Abstract of U.S. Patent No. 4,725,957: Date issued: 02/1988
S. D.	M	Abstract of U.S. Patent No. 4,728,888: Date issued: 03/1988
S. D.	N	Abstract of U.S. Patent No. 4,729,172: Date issued: 03/1988
S. D.	O	Abstract of U.S. Patent No. 4,731,727: Date issued: 03/1988
S. D.	P	Abstract of U.S. Patent No. 4,733,179: Date issued: 03/1988
S. D.	Q	Abstract of U.S. Patent No. 4,782,453: Date issued: 11/1988
S. D.	R	Abstract of U.S. Patent No. 4,784,237: Date issued: 11/1988
S. D.	T	Abstract of U.S. Patent No. 4,807,264: Date issued: 02/1989
S. D.	U	Abstract of U.S. Patent No. 4,835,870: Date issued: 06/1989
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Examiner: Serg. Febrey

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S. D.	B	Abstract of U.S. Patent No. 5,021,962: Date issued: 06/1991	
S. D.	C	Abstract of U.S. Patent No. 5,059,965: Date issued: 10/1991	
S. D.	D	Abstract of U.S. Patent No. 5,095,532: Date issued: 03/1992	
S. D.	E	Abstract of U.S. Patent No. 5,146,219: Date issued: 09/1992	
S. D.	F	Abstract of U.S. Patent No. 5,148,604: Date issued: 09/1992	
S. D.	G	Abstract of U.S. Patent No. 5,173,691: Date issued: 12/1992	
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S. D.	J	Abstract of U.S. Patent No. 5,184,123: Date issued: 02/1993	
S. D.	K	Abstract of U.S. Patent No. 5,193,214: Date issued: 03/1993	
S. D.	L	Abstract of U.S. Patent No. 5,247,252: Date issued: 09/1993	
S. D.	M	Abstract of U.S. Patent No. 5,261,279: Date issued: 11/1993	
S. D.	N	Abstract of U.S. Patent No. 5,279,040: Date issued: 01/1994	
S. D.	O	Abstract of U.S. Patent No. 5,283,575: Date issued: 02/1994	
S. D.	P	Abstract of U.S. Patent No. 5,332,180: Date issued: 07/1994	
S. D.	Q	Abstract of U.S. Patent No. 5,351,539: Date issued: 10/1994	
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S. D.	S	Abstract of U.S. Patent No. 5,406,490: Date issued: 04/1995	
S. D.	T	Abstract of U.S. Patent No. 5,416,711: Date issued: 05/1995	
S. D.	U	Abstract of U.S. Patent No. 5,438,687: Date issued: 08/1995	
S. D.	V	Abstract of U.S. Patent No. 5,440,389: Date issued: 08/1995	
S. D.	W	Abstract of U.S. Patent No. 5,465,088: Date issued: 11/1995	
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Examiner: Sayo Adachi

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S. D.	C	Abstract of U.S. Patent No. 5,508,917: Date issued: 04/1996	
S. D.	D	Abstract of U.S. Patent No. 5,515,042: Date issued: 05/1996	
S. D.	E	Abstract of U.S. Patent No. 5,523,765: Date issued: 06/1996	
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S. D.	I	Abstract of U.S. Patent No. 5,703,293: Date issued: 12/1997	
S. D.	J	Abstract of U.S. Patent No. 5,710,566: Date issued: 01/1998	
S. D.	K	Abstract of U.S. Patent No. 5,736,941: Date issued: 04/1998	
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S. D.	T	Abstract of U.S. Patent No. 5,850,190: Date issued: 12/1998	
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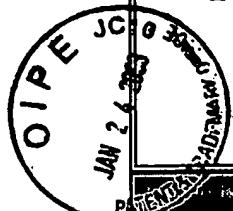
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Examiner: Sally SalazarDate Considered 9/28/2005

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Page 8 of 8		FILING DATE: February 14, 2002	GROUP ART UNIT: 2112



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Examiner: Seiji Tokunaga Date Considered 9/28/2005

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